## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination LEBONHEUR ET AL. Examiner Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,482,676 B2	11-2002	Tsunoi et al.	438/108
	В	US-6,051,093	04-2000	Tsukahara, Norihito	156/251
	С	US-6,815,831 B2	11-2004	Dias, Rajen C.	257/778
	D	US-6,790,758 B2	09-2004	Hsieh et al.	438/612
	Ε	US-6,111,628	08-2000	Shiota et al.	349/150
	F	US-2002/0109227 A1	08-2002	Liu et al.	257/737
	G	US-2004/0262778 A1	12-2004	Hua, Fay	257/778
	Н	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	ÚS-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
	R			·		
	S					
[	Т					

## **NON-PATENT DOCUMENTS**

*.		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	w	
	х	•

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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